

Room-temperature multiferroic behavior in layer-structured Aurivillius phase ceramics

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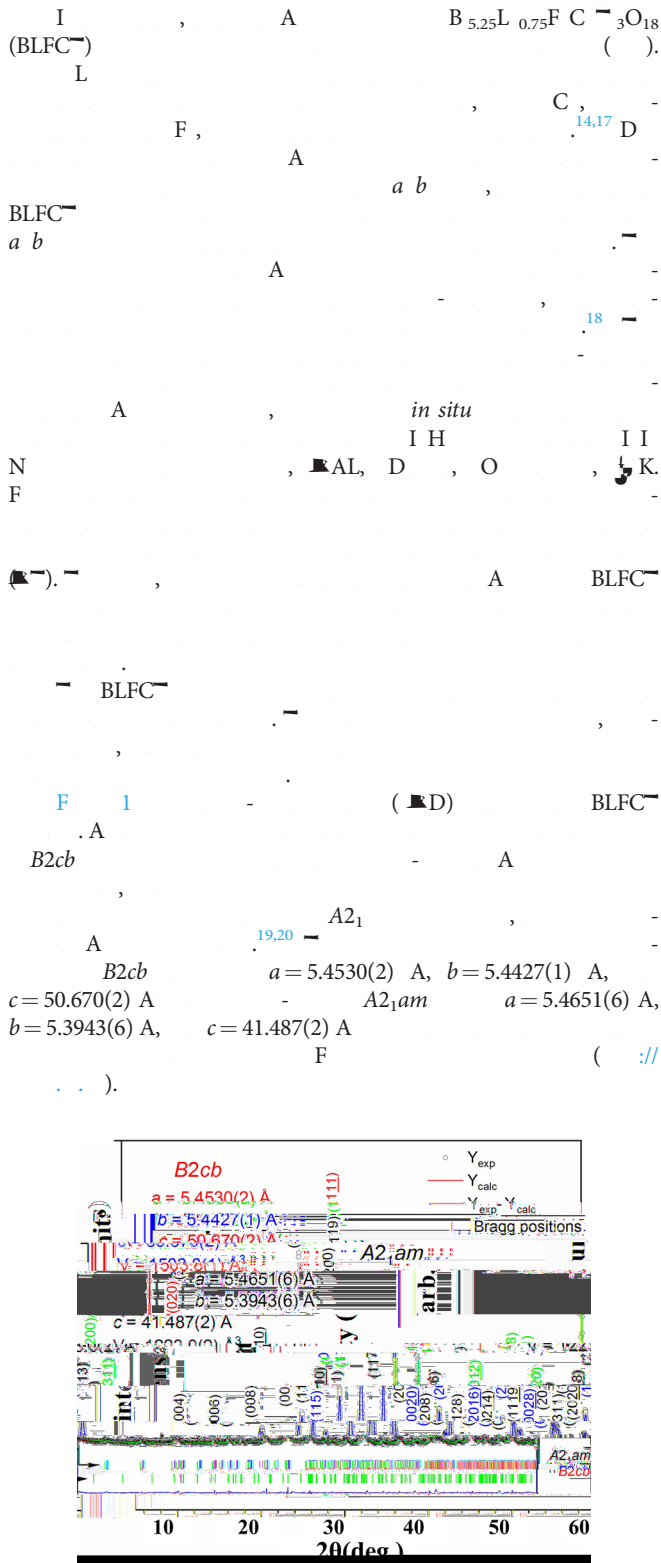


FIG. 1. XRD patterns of BLFC phases B2cb and A21am.

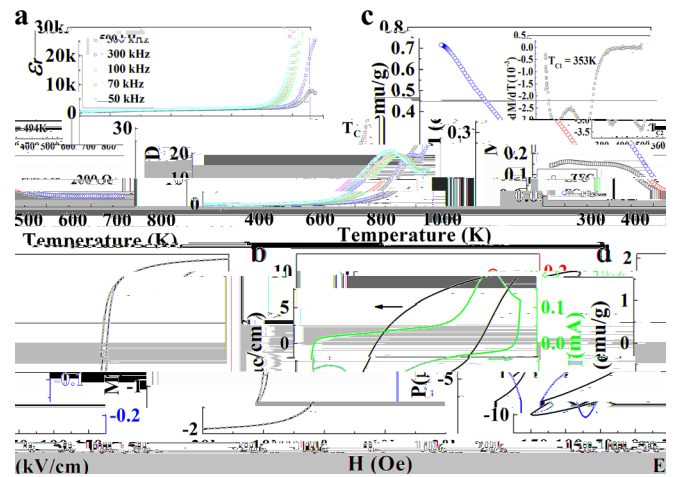
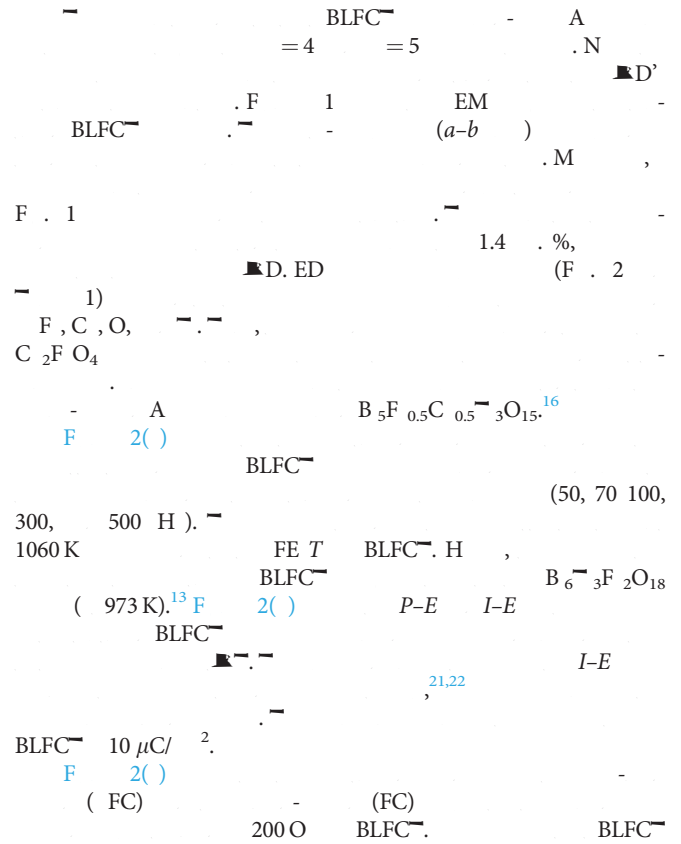


FIG. 2. (a) EPR spectra of BLFC phases at various frequencies. (b) Temperature dependence of the EPR signal. (c) Temperature dependence of the EPR signal. (d) Temperature dependence of the EPR signal. (e) Temperature dependence of the EPR signal.

$B_6FC_{18}O_{18}$ (526 K).²³ $T_C \sim 494$ K (M/),
 BLFC $F^{3+} O F^{3+}, C^{3+} O C^{3+}, F^{3+} O C^{3+}$ ().²⁴
 ED
 FC $T_2 \sim 353$ K
 $C_2F_2O_4$ (460 K) (M) $C_2F_2O_4$ 16,25
 $16.235 / 25$, 0.22 0.32 / , 1.4 %
 $C_2F_2O_4$ BLFC
 $M = 1.85 / , F = 2(1.1)$, M H
 $T_2 (F = 3)$ 425 K 1.58 / .
 0.27 / , ED
 BLFC
 A
 $F = 3$
 (DF) $F^{3+} O C^{3+}$ *ab initio*
 (A) H
 $\mu_F = 2$ $\mu_C = 3$ F C ,
 (GGA)+ μ . I
 BLFC
 $F = 3(1)$, F^{3+} C^{3+} (3.1 2.1 μ_B / ,),
 (0.1 μ_B /).
 $F O_6$ $C O_6$
 () F / C
 F O / $F = 3(1)$.
 F^{3+} C^{3+}
 (,)
 $E_{FM} - E_{AFM}$
 $= -144.1$.
 H , (FM)
 43.5 (, 504.6 K), FM
 T_1 FC/FC $F = 2(1)$ 2 ,
 a b
 010
 $F = 4$
 BLFC . I
 399 O .
 F .
 F -

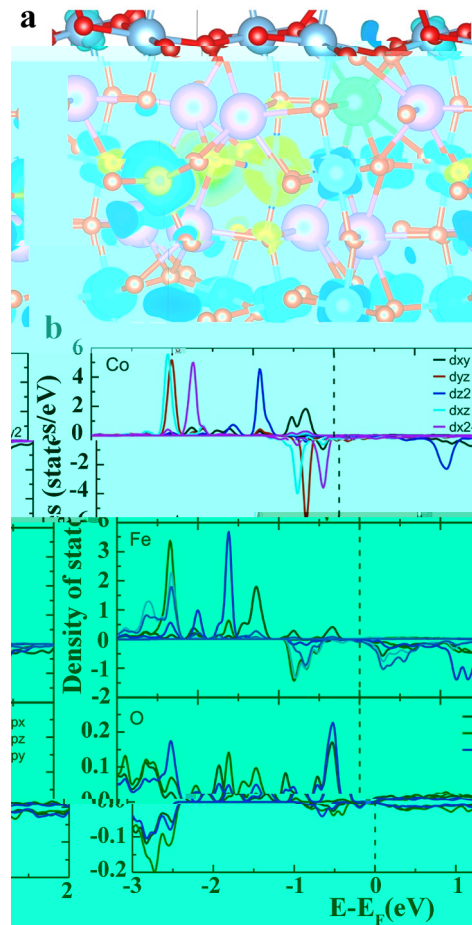


FIG. 3. (a) Crystal structure of BLFC showing layers of Co, Fe, and O atoms. (b) Density of states (DOS) plots for Co, Fe, and O atoms, showing contributions from dxy, dyz, dz2, dxz, and dx2-y2 orbitals. The energy axis is E-E_F (eV) from -3 to 1.

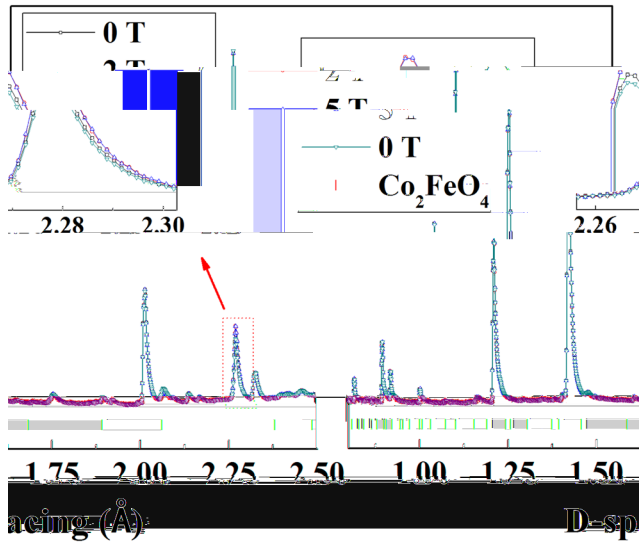


FIG. 4. XRD patterns of Co_2FeO_4 at 0 T and 2 T. The inset shows the magnified view of the peak at $2\theta \approx 2.24^\circ$.

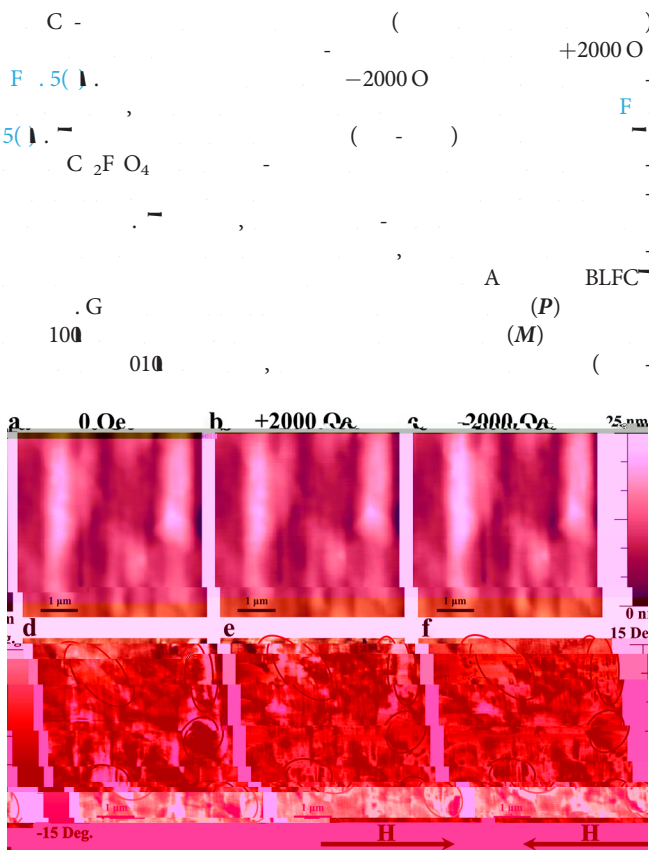


FIG. 5. MFM images of Co_2FeO_4 at different magnetic fields: (a) 0 Oe, (b) +2000 Oe, and (c) -2000 Oe. The images show the surface morphology and magnetic domains. Scale bars are 1 μm.

$T = P \times M$
 BLFC⁻
 I , A BLFC⁻
 F
 $\text{C}^{3+} \text{O} \text{C}^{3+}, \text{F}^{3+} \text{O} \text{C}^{3+}$
 $\text{F}^{3+} \text{O} \text{F}^{3+}$
 A , C / F
 EM (ED)
 BLFC⁻
 D . M , D . K , D .
 D I H I I N , AL,
 D , O , K .
 A E D F
 G A A (G N . 2/
 0038/20), C (G N . K2015-0602006), N FC (G
 N . 11474138 11834005). A
 E M (EM)
 IND54 N EM
 EM E AME E

DATA AVAILABILITY

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